


Search Notes 	Application/Control No. 10565106	Applicant(s)/Patent Under Reexamination HAN ET AL.
	Examiner M. Lee	Art Unit 2622

SEARCHED			
Class	Subclass	Date	Examiner
348	515, 518, 484	9/15/08	ml

SEARCH NOTES		
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east	9/15/08	ml

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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